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Polimerni materiali - Merjenje upornosti prevodne plastike

Plastics -- Measurement of resistivity of conductive plastics

Plastiques -- Mesurage de la résistivité des plastiques conducteurs

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International Standard



INTERNATIONAL ORGANIZATION FOR STANDARDIZATION®MEЖДУНАРОДНАЯ ОРГАНИЗАЦИЯ ПО СТАНДАРТИЗАЦИИ®ORGANISATION INTERNATIONALE DE NORMALISATION

Plastics — Measurement of resistivity of conductive plastics

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First edition - 1981-11-01

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Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards institutes (ISO member bodies). The work of developing International Standards is carried out through ISO technical committees. Every member body interested in a subject for which a technical committee has been set up has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work.

Draft International Standards adopted by the technical committees are circulated to the member bodies for approval before their acceptance as International Standards by the ISO Council.

International Standard ISO 3915 was developed by Technical Committee ISO/TC 61. VIEW Plastics, and was circulated to the member bodies in May 1980. (standards.iteh.ai)

It has been approved by the member bodies of the following countries :

		<u>SIST ISO 3915:1996</u>	
Australia	Germany.dErBs.iteh.ai/catalogRhilippinessist/5b993b59-fad7-4e36-96ec-		
Austria	Hungary	f691f8cbbRgmaniaso-3915-1996	
Belgium	India	South Africa, Rep. of	
Brazil	Ireland	Spain	
Canada	Israel	Sweden	
China	Italy	Switzerland	
Czechoslovakia	Japan	United Kingdom	
Egypt, Arab Rep. of	Korea, Rep. of	USA	
Finland	Mexico	USSR	
France	Netherlands		

No member body expressed disapproval of the document.

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Plastics — Measurement of resistivity of conductive plastics

0 Introduction

The method specified in this International Standard is technically similar to that specified for rubber in ISO 1853, Conducting and antistatic rubbers - Measurement of resistivity.

However, it differs from that method in certain details, especially those associated with the greater stiffness of the plastic samples, and in particular in the limitation on specimen width. It takes into account two problems encountered in the measurement of resistivity of conductive plastics, namely the sensitivity of these materials to their temperature-history and strain-history, and the difficulty of making adequate electrical contact with them.

standards.iteh.ai) The prescribed width of the specimen is mandatory for reference purposes; however, a wider strip may be used, with correspondingly wider electrodes. There is a danger in using a wide strip, if the strip is slightly twisted and at the same time lards/sAt stable a.c. current of magnitude (I) is passed between elecsomewhat non-uniform in its resistivity. It is then possible to ist-iso-trodies at the two ends of a strip of the material under test. The obtain erroneous results; the potential electrode nearer to the positive current electrode may even be found to be negative with respect to the other potential electrode.

Effect of temperature changes and strain on conductive plastics

As mentioned above, the resistance of these materials is sensitive to their temperature-history and strain-history. The relationships are complex and arise from the kinetic energy and structural configuration of the carbon particles in the polymer.

The resistivity may be increased by the effects of strain produced by (or subsequent to) removal from the mould, and a treatment is described for reducing specimens to a constant strain and temperature condition before measurements are carried out on them. Specimens are also cut in two perpendicular directions to assess anisotropy.

Electrode systems (see 3.3)

Certain types of electrode, when applied to these polymers, have a contact resistance which may be many thousand times greater than the intrinsic resistance of the specimen. Dry contacts under light pressure or point contacts give very high resistances. However, the present test method eliminates the effects of contact resistances unless these are excessively high. (In such a case, no result, rather than a wrong one, is generally obtained.)

Scope and field of application 1

This International Standard specifies the requirements for the laboratory testing of the resistivity of specially prepared specimens of plastics rendered conductive by the inclusion of carbon black. The test is suitable for materials of resistivity less than 10⁶ $\Omega \cdot cm$ (10⁴ $\Omega \cdot m$). The result is not strictly a volume resistivity, because of surface conduction, but the effects of the latter are generally negligible.

The principle of the four-terminal method of test is mandatory and the recommended specimen size and electrode design must be adhered to for reference purposes, but it may sometimes be necessary to test a wider strip with electrodes of a different construction.

2 Principle

voltage drop (ΔU) between two potential electrodes is measured with an electrometer. The resistance of the portion of the strip between the potential electrodes is given by $R = \Delta U/I$, and is independent of contact resistances. Thus the resistivity may be calculated.

3 Apparatus (see figure 1 for schematic diagram of test circuit)

3.1 Current source : a source of direct current which has a minimum resistance to earth of $10^{12} \Omega$ (effected by placing it on a highly insulating sheet), and which will not cause a dissipation of power greater than 0,1 W in the specimen.

3.2. Milliammeter or microammeter, as appropriate, for measuring the current to an accuracy of \pm 5 %.

NOTE - Small currents may be computed from measurement of the voltage drop across a known resistance in series with the specimen, using the electrometer (3.4)

3.3 Electrodes

3.3.1 Current electrodes, of clean metal, together with either suitable clamps or grips approximately 5 mm long and extending across the full width of the specimen, or conductive paint to cover the same area.

3.3.2 Potentiometric electrode system (see figure 2, for example), having a mass of approximately 60 g so that it exerts a force of approximately 0,6 N on the specimen. The contacts shall normally be 10 ± 0.2 mm apart. For special purposes, the contacts may be further apart (up to 70 mm), but the separation shall be less than the specimen length by at least 60 mm. The distance between the contacts shall be known to an accuracy of + 2 %. The insulation resistance between the contacts shall be at least $10^{12} \Omega$.

3.4 Electrometer, having an input resistance greater than 10¹¹ Ω and measuring to an accuracy of \pm 5 %.

3.5 Sheet of highly insulating material, having a volume resistivity greater than $10^{15} \Omega \cdot cm$.

3.6 Oven, capable of being maintained at a temperature of 70 ± 2 °C.

Specimen

The specimen shall be a strip 10 mm wide and 70 to 150 mm long and shall normally be 3 to 4 mm thick with a tolerance on uniformity of thickness of \pm 5 %. Thicker or thinner specimens may be cut from sheets or products. Care shall be taken to avoid bending or stretching the sheets or specimens, especially when they are thinner than standard.

The specimen may be cut with a knife or razor blade, but care must be taken to minimize distortion as this will affect the resistance R, in ohms, corresponding to tance values.

The surfaces of the specimen shall be clean; if necessary, they they may be cleaned by rubbing with fuller's earth (hydrated magnesium-aluminium silicate) and water, rinsing with distilled water and allowing to dry.1) The surfaces shall neither be buffed nor abraded, nor shall they be cleaned with organic materials that attack or swell the material.

Number of specimens 5

From each of two perpendicular directions, three specimens of equal size shall be prepared and tested. The two directions should, where possible, be chosen to be along and across any direction of flow during processing.

Procedure 6

6.1 After preparation, allow the specimen to remain at room temperature and ambient humidity conditions for at least 16 h.

6.2 Prior to the commencement of the test, connect the current electrodes (3.3.1) to the ends of the specimen, either by using the clamps or grips, or by covering the same area with conductive paint.

6.3 The required conditioning of the specimen should be described in the material specification. If this is not the case, the following procedure will probably be useful in most cases : Immediately after applying the current electrodes, place the specimen on the sheet of highly insulating material (3.5) and heat in the oven (3.6) for 2 h at a temperature of 70 \pm 2 °C to remove strains and irregularities caused by previous treatment. Cool for at least 1 h and test at 23 \pm 2 °C and 50 \pm 5 % relative humidity without disturbing the specimen. The specimen shall always be tested on the sheet of insulating material. With some materials, distortion may occur at 70 °C and heating for 5 h at 60 \pm 2 °C may then be preferable.

Place the potentiometric electrode system (3.3.2) on the 6.4 specimen, ensuring that the knife-edge contacts are at right angles to the direction of current flow and that neither potentiometric electrode is within 20 mm of a current electrode. Apply the current and measure the voltage drop between the potentiometric electrodes using the electrometer (3.4).

Repeat the measuring procedure twice more on the same specimen, moving the potentiometric electrodes each time to obtain measurements over lengths of specimen evenly distributed between the current electrodes.

6.5 Test the other five specimens similarly.

standards iteh ai) Expression of results

https://standards.iteh.ai/catalog/staneach.position.of.the.potentiometric electrodes, using the for-

$$R = \frac{\Delta U}{I}$$

where

 ΔU is the voltage drop, in volts, between the potentiometric electrodes;

I is the current, in amperes, through the specimen.

7.2 The resistivity ρ , expressed in ohm centimetres, is given by the formula

$$\varrho = \frac{R \times A}{d}$$

where

R is the resistance, in ohms, calculated in accordance with 7.1:

A is the cross-sectional area, in square centimetres, of a specimen perpendicular to the current flow (see figure 3);

1) If a particular drying method is necessary, it should be stated in the material specification.

d is the distance, in centimetree, between the potentio-metric electrodes.

For each direction of current flow, determine the median of the nine resistivity values thus calculated.

8 Test report

The test report shall include the following particulars :

a) reference to this International Standard;

b) complete identification of the sample, including processing details if relevant;

c) dimensions of the test specimen;

d) conditioning, if different from that described in 6.3, or if the 60 $^{\circ}$ C conditioning is used;

- e) the distance between the potentiometric electrodes;
- f) the average value of voltage drop measured;

g) the individual resistivity values and the medians of the results in the two directions of test;

h) any other details that may have had an effect on the test results.

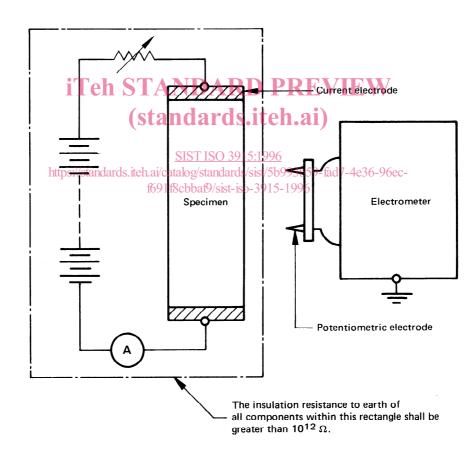
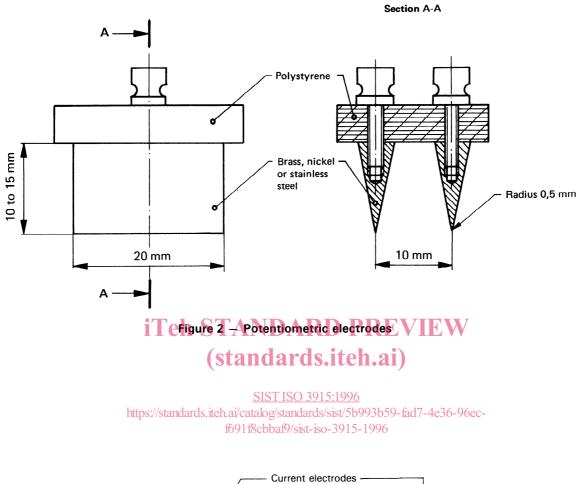


Figure 1 - Schematic diagram of test circuit



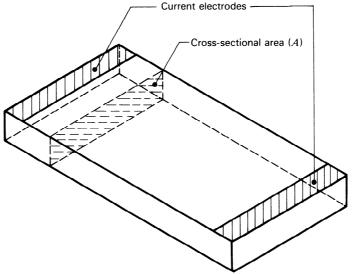


Figure 3 - Test specimen